

Laboratory **Instrument Calibration Center, 416, Maruti Plaza, Bapa Shitaram Chowk Road, Krishnanagar, Naroda, Ahmedabad, Gujarat**

Accreditation Standard **ISO/IEC 17025: 2005**

Certificate Number **CC-2683 (In lieu of C-1368, C-1369)**

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Validity **05.05.2018 to 04.05.2020**

Last Amended on **18.05.2018**

Sl.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (\pm)	Remarks
<u>ELECTRO-TECHNICAL CALIBRATION</u>				
I.	SOURCE			
1.	DC Voltage [§]	0.1 mV to 1 mV 1 mV to 100 mV 100 mV to 1000 V	4.6% to 0.38% 0.38% to 0.015% 0.015% to 0.009%	Using MFC Fluke - 5502E By Direct Method
2.	DC Ampere [§]	10 uA to 3 mA 3 mA to 300 mA 300 mA to 20 A	0.27% to 0.023% 0.023% to 0.06% 0.06% to 0.15%	Using MFC Fluke - 5502E By Direct Method
3.	AC Voltage [§]	50Hz 2mV to 10m V 10mV to 100 mV 100 mV to 1 V 1 V to 1000 V	1.4% to 0.35% 0.35% to 0.09% 0.08% to 0.044% 0.044% to 0.092%	Using MFC Fluke - 5502E By Direct Method
4.	AC Amps [§]	50 Hz 30 uA to 300 mA 300 mA to 20A	0.54% to 0.12% 0.12% to 0.23%	Using MFC Fluke - 5502E By Direct Method
5.	Capacitance [§]	1 kHz 1 nF to 1 uF 10 nF to 30 uF 30 uF to 1 mF	1.9% to 0.47% 0.47% to 0.95% 0.95% to 0.96%	Using MFC Fluke - 5502E By Direct Method
6.	Resistance [§]	1 Ω to 100 Ω 100 Ω to 1M Ω 1 M Ω to 100 M Ω 100M Ω to 1G Ω	0.077% to 0.0105% 0.0105% to 0.013% 0.013% to 0.58% 0.58% to 1.7%	Using MFC Fluke - 5502E By Direct Method

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Convenor

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7.	Frequency [§]	10Hz to 100 kHz 100 kHz to 1 MHz	0.015% to 0.0014% 0.0014% to 1.9%	Using MFC Fluke - 5502E By Direct Method
8.	High Resistance For Insulation Tester [§]	0.1 M Ω to 100 M Ω 100 M Ω to 10 G M Ω	0.6368% to 0.58% 0.58% to 3.47%	Using Mega ohm Resistance Discreet value in step of 10 By Direct Method
9.	Low Resistance Box [§]	10 m Ω to 2 k Ω	1.23% to 1.16%	Using Low resistance for milliohm meter Discreet value steps of 1/2/5 by Direct Method
10.	Temperature Simulation [§] Pt 100 J Type Thermocouple K Type Thermocouple	(-)200 °C to 600 °C (-)200 °C to 1100 °C (-)200 °C to 1300 °C	0.42 °C 0.2 °C 0.21 °C	Using Fluke - 5502E By Simulation Method
II.	MEASURE			
1.	DC Voltage [§]	10mV to 100mV 100mV to 1V 1V to 1000V	0.06% to 0.01% 0.01% to 0.01% 0.007% to 0.01%	Using Tektronix 4050 By Direct Method
2.	AC Voltage [§]	50 Hz 10mV to 100Mv 100mV to 1V 1V to 1000V	0.66% to 0.12% 0.12% 0.12% to 0.13%	Using Tektronix 4050 By Direct Method
3.	DC Ampere [§]	10uA to 10mA 10mA to 1 A 1A to 10A	0.41% to 0.1% 0.1% 0.1% to 0.22%	Using Tektronix 4050 By Direct Method

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4.	AC Ampere ^s	50 Hz 30 μ A to 10mA 10mA to 1A 1A to 10A	1.4% to 0.5% 0.5% to 0.18% 0.18% to 0.26%	Using Tektronix 4050 By Direct Method
5.	Resistance ^s	1 Ω to 10 Ω 10 Ω to 100 Ω 100 Ω to 1M Ω 1M Ω to 1000M Ω	0.89% to 1.3% 1.3% to 0.02% 0.02% to 0.014% 0.014% to 2.3%	Using Tektronix 4050 By Direct Method
6.	Capacitance ^s	1nF to 100 μ F 100 μ F to 1mF	5.7%to 1.8% 1.8% to 2.11%	Using Tektronix 4050 By Direct Method
7.	Frequency ^s	50Hz to 100kHz 100kHz to 1MHz	0.06% to 0.01% 0.01 %to 0.13%	Using Tektronix 4050 By Direct Method
8.	AC High Voltage*	1kV to 27 kV	7.3%	Using Fluke 80K-40 by Direct Method
9.	DC High Voltage*	1 kV to 40 kV	2.33%	Using Fluke 80K-40 by Direct Method
10.	Time ^s	5 Sec to 3600 Sec 3600 to 7200 Sec	0.23 Sec 0.7 Sec	Using Master Stopwatch by Comparison Method

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<u>MECHANICAL CALIBRATION</u>				
I. DIMENSION (BASIC MEASURING INSTRUMENT, GAUGE ETC.)				
1.	Caliper ^s (Vernier/Dial/Digital) L.C. 10 μ m	0 to 600 mm 0 to 1000 mm	13.0 μ m 17.0 μ m	Using Caliper Checker, Length bar, & External Micrometer by Comparison Method
2.	Depth Caliper ^s (Vernier / Dial/Digital) L.C. 10 μ m	0 to 300 mm	9.0 μ m	Using gauge Block Set & Surface plate By comparison method
3.	Height Gauge ^s (Vernier/Dial/Digital) L.C. 10 μ m	0 to 600 mm	13.0 μ m	Using Caliper Checker & Surface plate By Comparison Method
4.	External Micrometer ^s (Analog/Dial/Digital) L.C. 1 μ m L.C. 10 μ m	0 to 150 mm 0 to 300 mm 150 mm to 300mm 300mm to 600mm	2.8 μ m 6.8 μ m 6.8 μ m 11.1 μ m	Using Gauge Block set, Long Gauge blocks & Mic. Check Set By comparison Method

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Sl.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (\pm)	Remarks
5.	Micrometer Setting Road ^{\$}	25mm to 275 mm	5.0 μ m	Using Gauge Block Set, Electronic probe & Comparator Stand By comparison Method
6.	Depth Micrometer ^{\$} L.C. 10 μ m	0 to 300 mm	8.7 μ m	Using Gauge Block Set & Surface Plate by Comparison Method
7.	Plunger Dial Gauge ^{\$} L.C. 10 μ m	0 to 25 mm	3.5 μ m	Using Dial Calibration tester By Comparison Method
8.	Lever Dial gauge ^{\$} L.C. 1 μ m	0 to 1 mm	3.9 μ m	Using Dial calibration Tester by Comparison Method
9.	Bore gauge transmission Error ^{\$} L.C. 10 μ m	Up to 1.0 mm	7.1 μ m	Using Dial Calibration Tester By comparison Method
10.	Dial/Digital Thickness gauge ^{\$} L.C. 1 μ m	0 to 25 mm	1.1 μ m	Using gauge Block Set By comparison Method

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11.	Plain plug gauge ^s	5mm to100 mm	2.5 μ m	Using Gauge Block Set, Electronic Probe & comparator Stand By comparison Method
12.	Cylindrical Measuring pin ^s	Up to 20.0 mm	1.8 μ m	Using Gauge Block Set, Electronic probe & Comparator Stand By Comparison Method
13.	Feeler gauge ^s	Up to 1 mm	1.7 μ m	Using Gauge Block Set, Electronic Probe & Comparator Stand By Comparison Method
14.	Bevel Protractor ^s L.C. 1'	0°-90°-0°	1.4 min of arc	Using Angle gauge blocks By Comparison Method
II.	DIMENSION (PRECISION INSTRUMENTS)			
1.	Dial Calibration Tester ^s	0 to 25 mm	1.6 μ m	Using Gauge Block Set, Electronic probe & Comparator Stand By Comparison Method

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III.	ACCELERATION AND SPEED			
1.	Contact Type Tachometer [§]	100 rpm to 1000 rpm >1000 rpm to 9990 rpm	0.36 % 0.06 %	Using Digital Tachometer & Servo Motor Drive Source by Comparison Method
	Non-Contact type Tachometer [§]	500 rpm to 1000 rpm >1000 rpm to 99900 rpm	0.37% 0.06 %	
IV.	ACOUSTICS			
1.	Sound Level Meter [§]	94 & 114 dB	1.0 dB	Using Sound level Calibrator By Comparison Method
V.	PRESSURE INDICATING DEVICES			
1.	Pressure indicator [#] (Pneumatic)	0 to 0.5 bar	0.0019 bar	Using Digital Pneumatic calibrator By comparison Method as per DKD R-6-1
2.	Pressure indicator [#] (Hydraulic)	0 to 400 bar	0.91bar	Using Digital Pressure Calibrator with hydraulic pump By comparison Method as per DKD R-6-1

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<u>THERMAL CALIBRATION</u>				
I.	TEMPERATURE			
1.	Indicator of Liquid Bath, Furnace Oven, Environmental Chamber, Dry Block Bath, Etc [*]	(-)80°C to 400 °C	0.9°C	Using RTD Sensor & 6 ½ DMM, By Comparison Method at specified single location

* Measurement Capability is expressed as an uncertainty (\pm) at a confidence probability of 95%

[§] Only in Permanent Laboratory

[^] Only for Site Calibration

[#] The laboratory is also capable for site calibration however, the uncertainty at site depends on the prevailing actual environmental conditions and master equipment used.

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